

estel[®]**ESTEL ELEKTROONIKA**
ESTONIA**April**
2005**Series**
TFI343-500**High Frequency Inverter grade**
Capsule Thyristor
Type TFI343-500Low switching losses
Low reverse recovery charge
Distributed amplified gate for high di/dt

| | | | | | | | | |
|---|------------|---------------------------------|------|------|------|------|------|------|
| Maximum mean on-state current | I_{TAV} | 500 A | | | | | | |
| Maximum repetitive peak off-state and reverse voltage | U_{DRM} | 1200 ÷ 2200 V | | | | | | |
| Turn-off time | U_{RRM} | 25; 32 μs | | | | | | |
| | t_q | 25; 32 μs | | | | | | |
| U_{DRM}, U_{RRM}, V | 1200 | 1300 | 1400 | 1500 | 1600 | 1800 | 2000 | 2200 |
| Voltage code | 12 | 13 | 14 | 15 | 16 | 18 | 20 | 22 |
| $T_{vj}, ^\circ C$ | - 60 ÷ 125 | | | | | | | |

MAXIMUM ALLOWABLE RATINGS

| Symbols and parameters | | Units | TFI343-500 | Conditions |
|------------------------|---|------------|--------------|--|
| I_{TAV} | Mean on-state current | A | 500 768 | $T_c=85^\circ C$, $T_c=55^\circ C$, 180° half-sine wave, 50 Hz |
| I_{TRMS} | RMS on-state current | A | 785 | $T_c=85^\circ C$ |
| I_{TSM} | Surge on-state current | kA | 10,0 11,0 | $T_{vj}=125^\circ C$ $T_{vj}=25^\circ C$ |
| I^2t | Limiting load integral | kA^2s | 500 605 | $T_{vj}=125^\circ C$ $T_{vj}=25^\circ C$ |
| U_{DRM}, U_{RRM} | Repetitive peak off-state and reverse voltage | V | 1200÷2200 | $T_j \min \leq T_{vj} \leq T_{jM}$ 180° half-sine wave, 50 Hz Gate open |
| U_{DSM}, U_{RSM} | Non-repetitive peak off-state and reverse voltage | V | 1300÷2300 | $T_j \min \leq T_{vj} \leq T_{jM}$ 180° half-sine wave $t_p=10$ ms, Single pulse Gate open |
| $(di_T/dt)_{crit}$ | Critical rate of rise of on-state current : non - repetitive repetitive | $A/\mu s$ | 2000 1250 | $T_{vj}=125^\circ C$; $U_D=0,67 U_{DRM}$, Gate pulse : 10V, 5 Ω , 1 μs rise time, 10 μs |
| U_{RGM} | Peak reverse gate voltage | V | 5 | $T_j \min \leq T_{vj} \leq T_{jM}$ |
| T_{stg} | Storage temperature | $^\circ C$ | -60÷80 | |
| T_{vj} | Junction temperature | $^\circ C$ | -60÷125 | |

CHARACTERISTICS

| | | | | |
|------------------------|---|-----------|----------|--|
| U_{TM} | Peak on-state voltage | V | 2,4 | $T_{vj}=25^\circ C$, $I_{TM}=3,14 I_{TAV}$ |
| $U_{T(TO)}$ | Threshold voltage | V | 1,5 | $T_{vj}=125^\circ C$ |
| R_T | On-state slope resistance | $m\Omega$ | 0,62 | 1,57 $I_{TAV} < I_T < 4,71 I_{TAV}$ |
| I_{DRM} I_{RRM} | Repetitive peak off-state and reverse current | mA | 70 70 | $T_{vj}=125^\circ C$, $U_D = U_{DRM}$ $U_R = U_{RRM}$ |

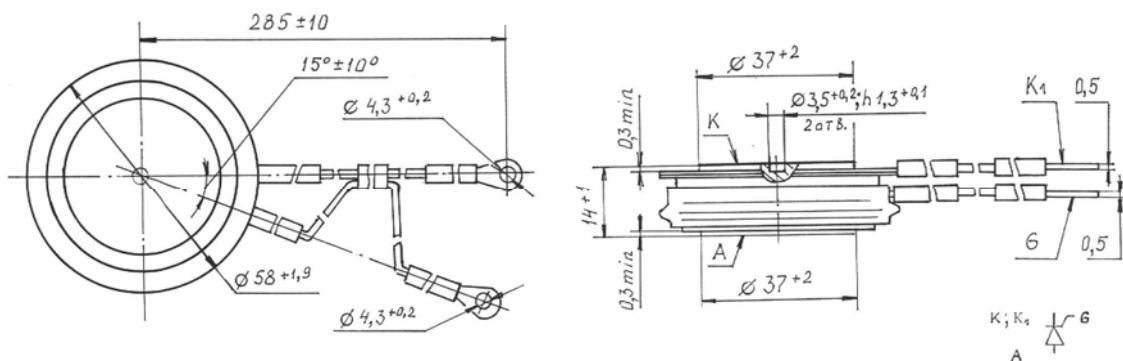
CHARACTERISTICS

| Symbols and parameters | | Units | TFI343-500 | Conditions |
|------------------------|--|-----------------------------|------------------------------|--|
| I_L | Latching current | A | 8 | $T_{vj}=25^{\circ}\text{C}, U_D=12\text{V}$ Gate pulse : 10V, 5 Ω , 1 μs rise time, 10 μs |
| I_H | Holding current | A | 0,5 | $T_{vj}=25^{\circ}\text{C}, U_D=12\text{V}$, Gate open |
| U_{GT} | Gate trigger direct voltage | V | 2,5 5,0 | $T_{vj}=25^{\circ}\text{C}$, $T_{vj}=-60^{\circ}\text{C}$ $U_D=12\text{V}$ |
| I_{GT} | Gate trigger direct current | A | 0,3 0,8 | $T_{vj}=25^{\circ}\text{C}$, $T_{vj}=-60^{\circ}\text{C}$ |
| U_{GD} | Gate non-trigger direct voltage | V | 0,25 | $T_{vj}=125^{\circ}\text{C}, U_D = 0,67 U_{DRM}$ |
| I_{GD} | Gate non-trigger direct current | mA | 10 | Direct gate current |
| t_{gd} | Delay time | μs | 1,6 | $T_{vj}=25^{\circ}\text{C}, U_D=500\text{V}$ $I_{TM} = 500\text{ A}$ |
| t_{gt} | Turn-on time | μs | 2,5 | Gate pulse : 10V, 5 Ω , 1 μs rise time, 10 μs |
| t_q | Turn-off time | μs | 25 \div 32 32 \div 40 | $T_{vj}=125^{\circ}\text{C}, I_{TM}=500\text{ A}$ $di_R/dt = 10\text{ A}/\mu\text{s}, U_R=100\text{V}$ $U_D = 0,67 U_{DRM}$ $du_D/dt=50\text{ V}/\mu\text{s}$ $du_D/dt=200\text{ V}/\mu\text{s}$ |
| Q_{rr} | Recovered charge | μC | 350 | $T_{vj}=125^{\circ}\text{C}, I_{TM}=500\text{ A}$ $di_R/dt = 50\text{ A}/\mu\text{s}, U_R=100\text{V}$ |
| t_{rr} | Reverse recovery time | μs | 5,0 | |
| I_{rrM} | Peak reverse recovery current | A | 140 | |
| $(du_D/dt)_{crit}$ | Critical rate of rise of off-state voltage | V/ μs | 500 1000 | $T_{vj}=125^{\circ}\text{C}, U_D = 0,67 U_{DRM}$ Gate open |
| R_{thjc} | Thermal resistance junction to case | $^{\circ}\text{C}/\text{W}$ | 0,034 | Direct current, double side cooled |

ORDERING

| | TFI | 343 | 500 | 20 | 7 | 5 | 3 | |
|--|-----|-----|-----|----|---|---|---|--|
| | 1 | 2 | 3 | 4 | 5 | 6 | 7 | |

1. Fast thyristor with interdigitated gate structure.
2. Design version.
3. Mean on-state current, A.
4. Voltage code (20=2000V).
5. Critical rate of rise of off-state voltage ($6 \geq 500\text{ V}/\mu\text{s}$, $7 \geq 1000\text{ V}/\mu\text{s}$)
6. Group of turn-off time ($du_D/dt=50\text{ V}/\mu\text{s}$, $4 \leq 32\ \mu\text{s}$, $5 \leq 25\ \mu\text{s}$)
7. Group of turn-on time ($3 \leq 2,5\ \mu\text{s}$).



Mounting force : 13 \div 19 kN

Weight : 210 grams

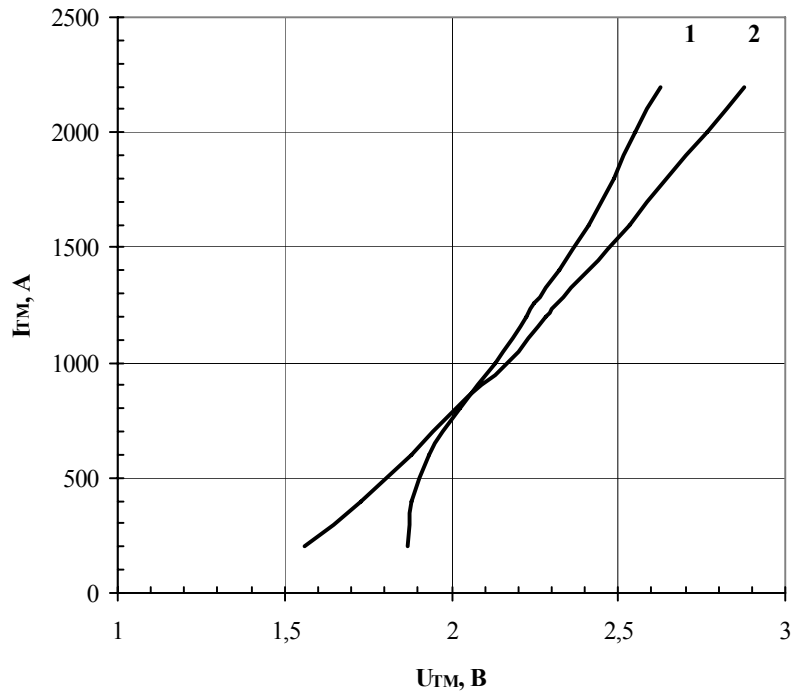
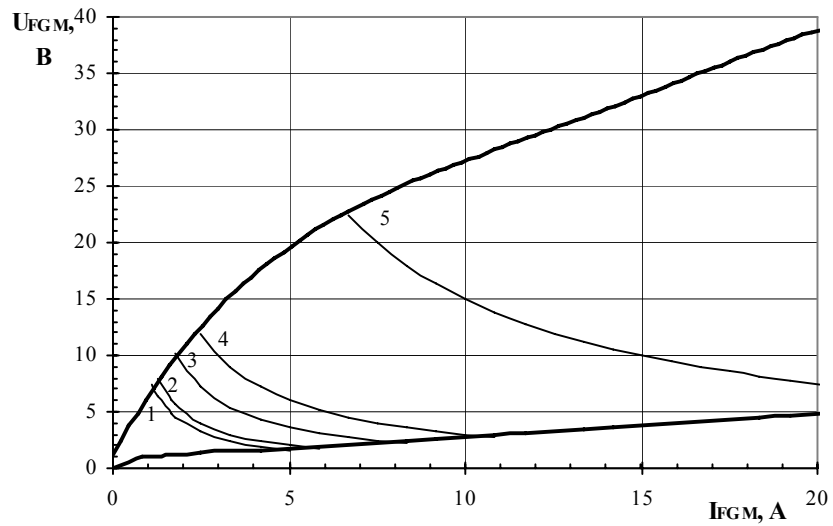


Fig. 1 On-state characteristics of Limit device
 1 – $T_j=25\text{ }^\circ\text{C}$
 2 – $T_j=125\text{ }^\circ\text{C}$



Maximum peak gate power loss

| Position | On-Off time ratio | Gate pulse length, ms | Gate Pulse Power, W |
|----------|-------------------|-----------------------|---------------------|
| 1 | 1 | DC | 8 |
| 2 | 2 | 10 | 10 |
| 3 | 20 | 1 | 18 |
| 4 | 40 | 0.5 | 30 |
| 5 | 200 | 0.1 | 150 |

Fig. 2 Gate characteristics

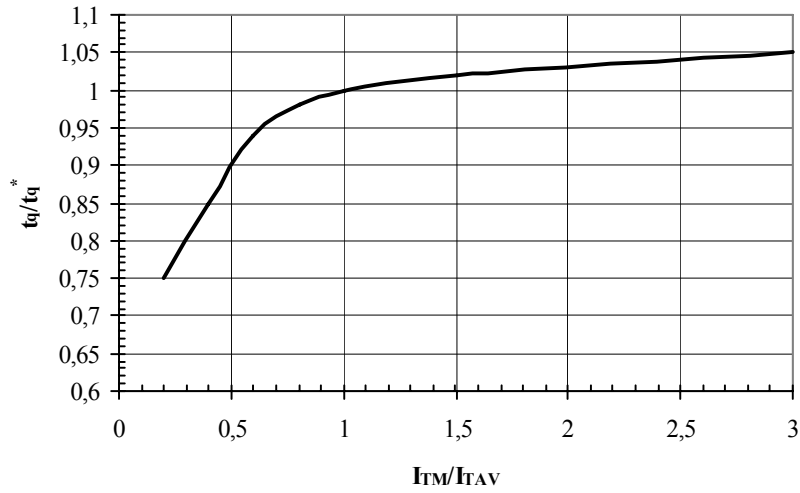


Fig. 3 Turn-off time t_q vs. On-state peak current I_{TM}

Conditions: $T_j=T_{j\max}$; $di_R/dt=10\text{ A}/\mu\text{s}$; $V_R=100\text{ V}$; $dv_D/dt=50\text{ V}/\mu\text{s}$; $V_D=0.67\cdot V_{DRM}$
 Typical changes of t_q are normalized to the t_q^* (t_q^* – see data sheet, $dv_D/dt=50\text{ V}/\mu\text{s}$)

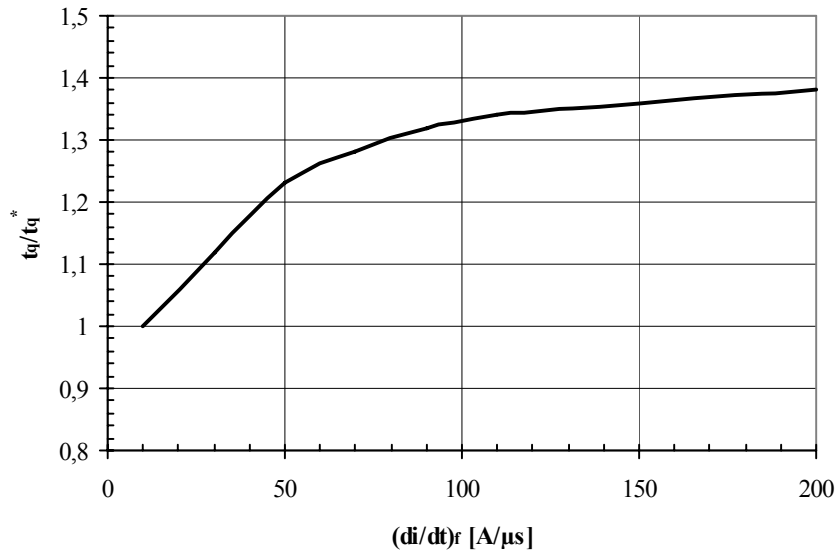


Fig. 4 Turn-off time t_q vs. Rate of fall of on-state current di_R/dt

Conditions: $T_j=T_{j\max}$; $I_{TM}=I_{TAV}$; $V_R=100\text{ V}$; $dv_D/dt=50\text{ V}/\mu\text{s}$; $V_D=0.67\cdot V_{DRM}$
 Typical changes of t_q are normalized to the t_q^* (t_q^* – see data sheet, $dv_D/dt=50\text{ V}/\mu\text{s}$)

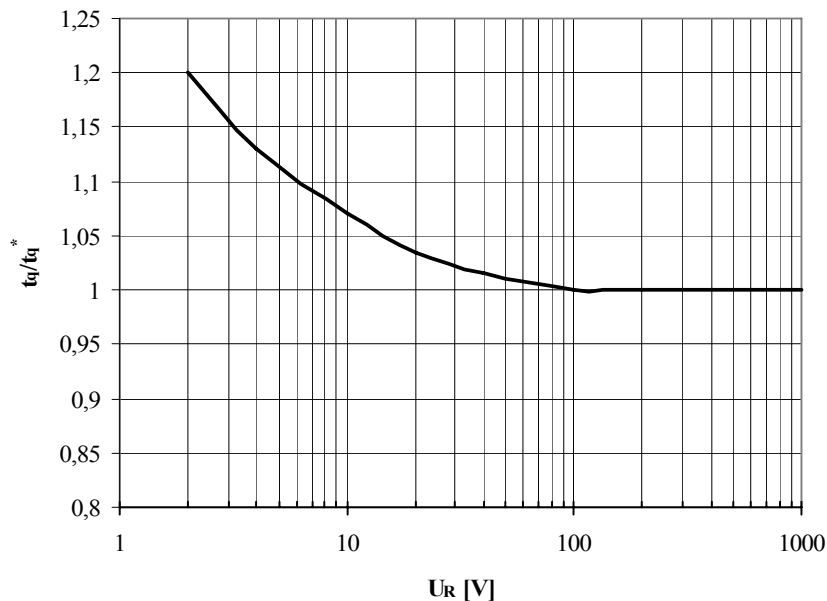


Fig. 5 Turn-off time t_q vs. Reverse voltage V_R

Conditions: $T_j=T_{j\max}$; $I_{TM}=I_{TAV}$; $di_R/dt=10\text{ A}/\mu\text{s}$; $dv_D/dt=50\text{ V}/\mu\text{s}$; $V_D=0.67\cdot V_{DRM}$
 Typical changes of t_q are normalized to the t_q^* (t_q^* – see data sheet, $dv_D/dt=50\text{ V}/\mu\text{s}$)

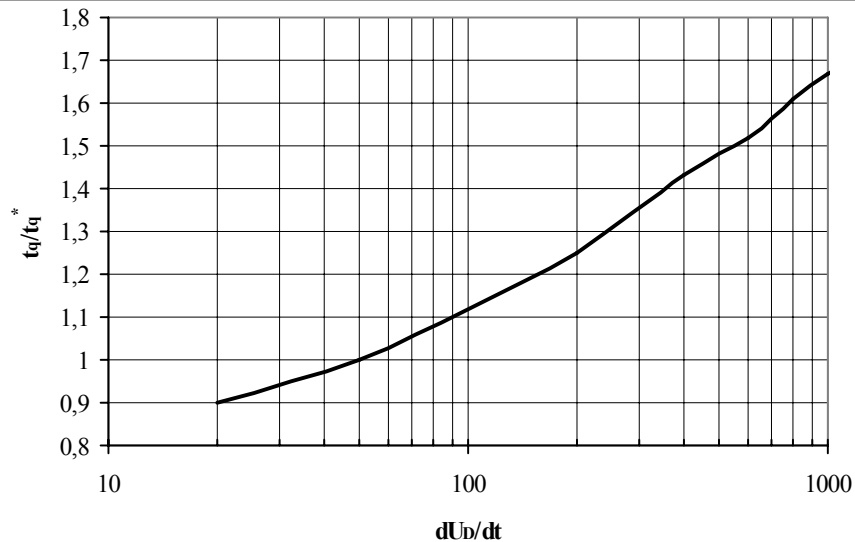


Fig. 6 Turn-off time t_q vs. Rate of rise of commutating voltage dv_D/dt

Conditions: $T_j=T_{j\max}$; $I_{TM}=I_{TAV}$; $di_R/dt=10\text{ A}/\mu\text{s}$; $V_R=100\text{ V}$; $V_D=0.67\cdot V_{DRM}$
 Typical changes of t_q are normalized to the t_q^* (t_q^* – see data sheet, $dv_D/dt=50\text{ V}/\mu\text{s}$)

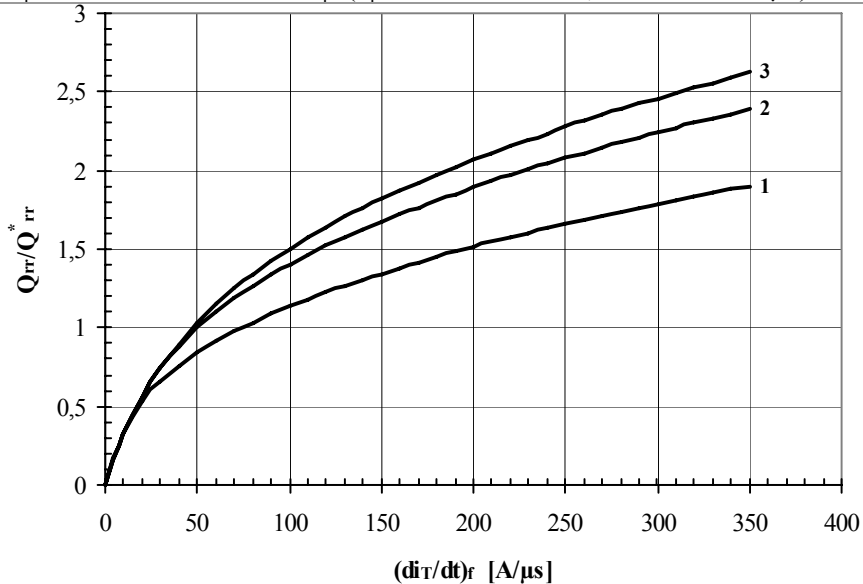


Fig. 7 Reverse recovery charge Q_{rr} , vs. Rate of fall of on-state current di_R/dt

- 1 – $I_{TM} = 0.5 \cdot I_{TAV}$
- 2 – $I_{TM} = I_{TAV}$,
- 3 – $I_{TM} = 1.5 \cdot I_{TAV}$

Conditions: $T_j=T_{j\max}$; $V_R=100\text{ V}$

Typical changes of Q_{rr} are normalized to the Q_{rr}^* (Q_{rr}^* – see data sheet)

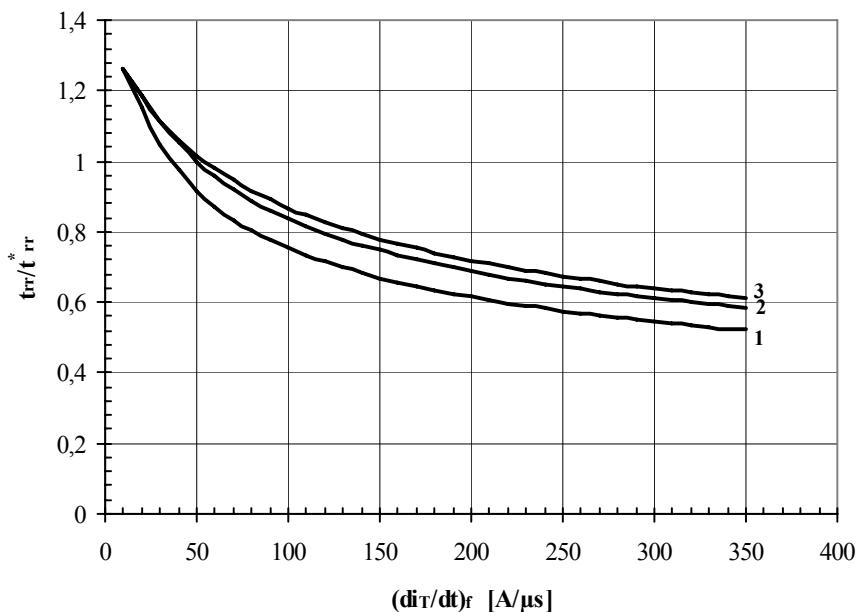


Fig. 8 Reverse recovery time t_{rr} vs. Rate of fall of on-state current di_R/dt

1 – $I_{TM} = 0.5 \cdot I_{TAV}$

2 – $I_{TM} = I_{TAV}$,

3 – $I_{TM} = 1.5 \cdot I_{TAV}$

Conditions: $T_j = T_{j \max}$; $V_R = 100$ V

Typical changes of t_{rr} are normalized to the t_{rr}^* (t_{rr}^* – see data sheet)

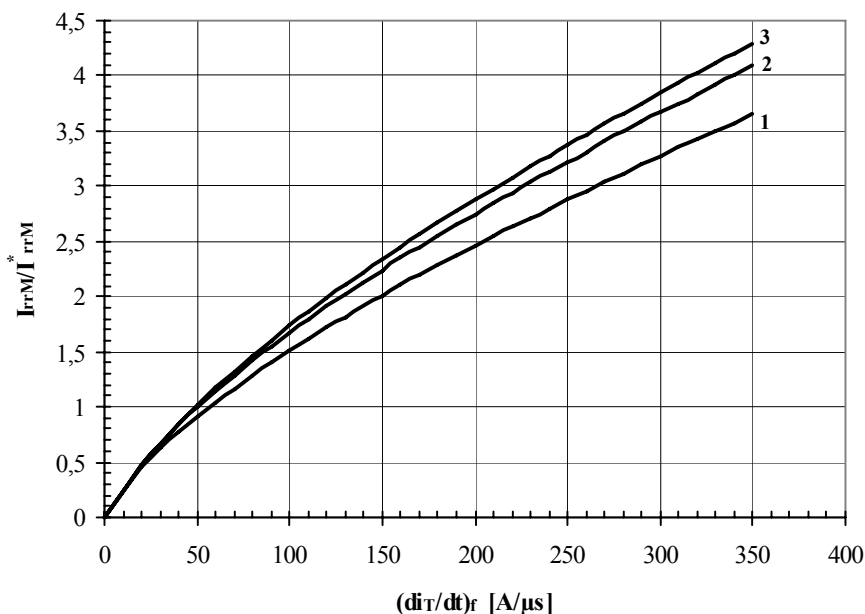


Fig. 9 Peak reverse recovery current I_{rrM} vs. Rate of fall of on-state current di_R/dt

1 – $I_{TM} = 0.5 \cdot I_{TAV}$

2 – $I_{TM} = I_{TAV}$,

3 – $I_{TM} = 1.5 \cdot I_{TAV}$

Conditions: $T_j = T_{j \max}$; $V_R = 100$ V

Typical changes of I_{rrM} are normalized to the I_{rrM}^* (I_{rrM}^* – see data sheet)

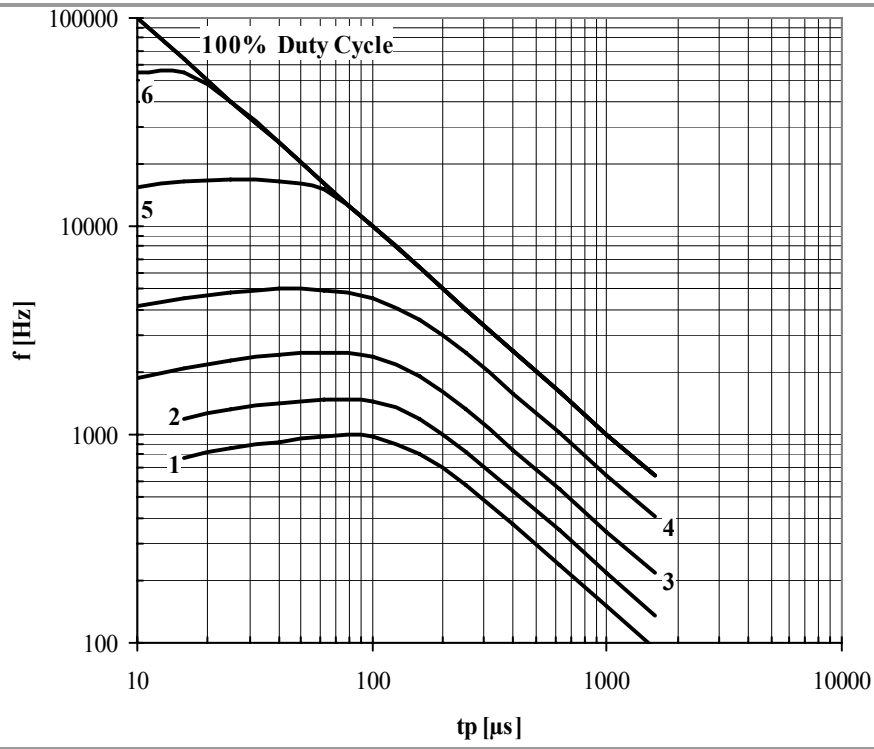


Fig. 10 Sine wave frequency ratings

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A

Conditions: $V_R \leq 3$ V; $T_C = 55$ °C

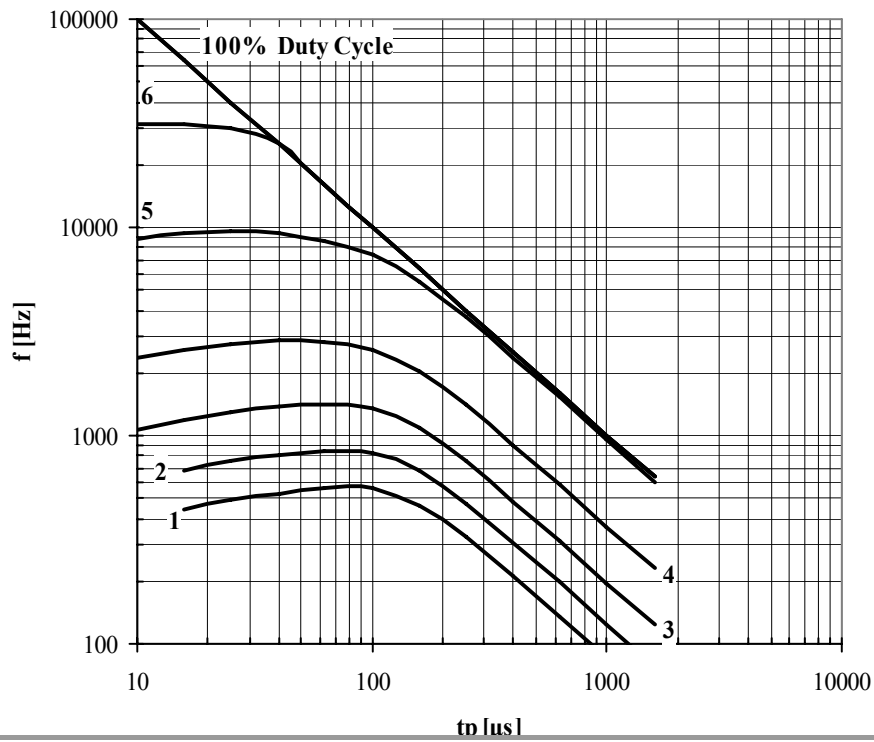


Fig. 11 Sine wave frequency ratings

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $T_C = 85$ °C

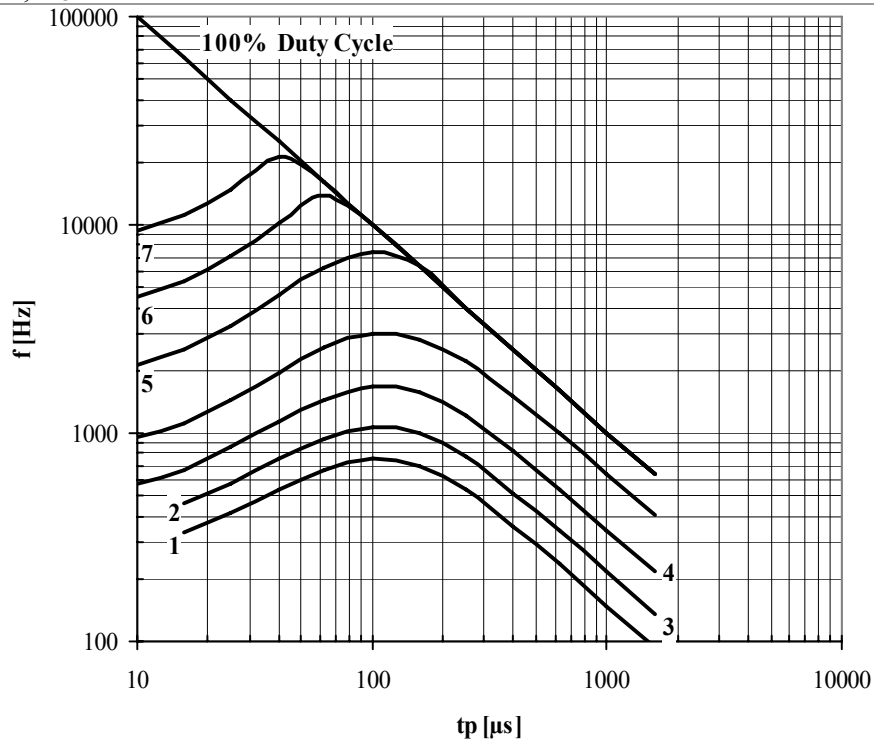


Fig. 12 Sine wave frequency ratings

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 55$ °C

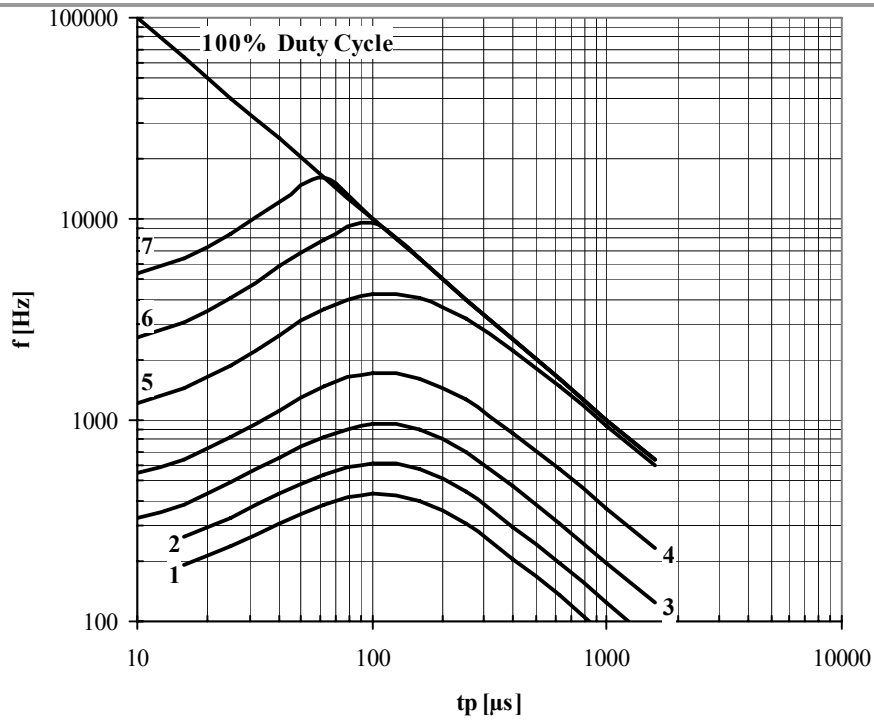


Fig. 13 Sine wave frequency ratings

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R = 0.67 V_{RRM}$; $T_C = 85^\circ\text{C}$

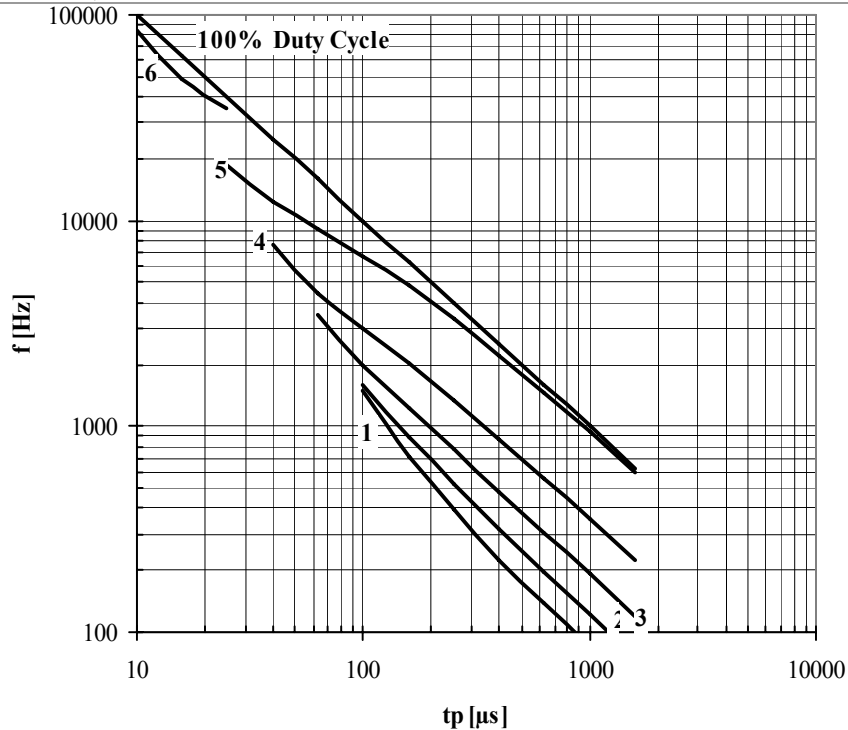


Fig. 14 Square wave frequency ratings

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A

Conditions: $V_R \leq 3 \text{ V}$; $T_C = 55 \text{ }^\circ\text{C}$; $di_F/dt = di_R/dt = 100 \text{ A}/\mu\text{s}$

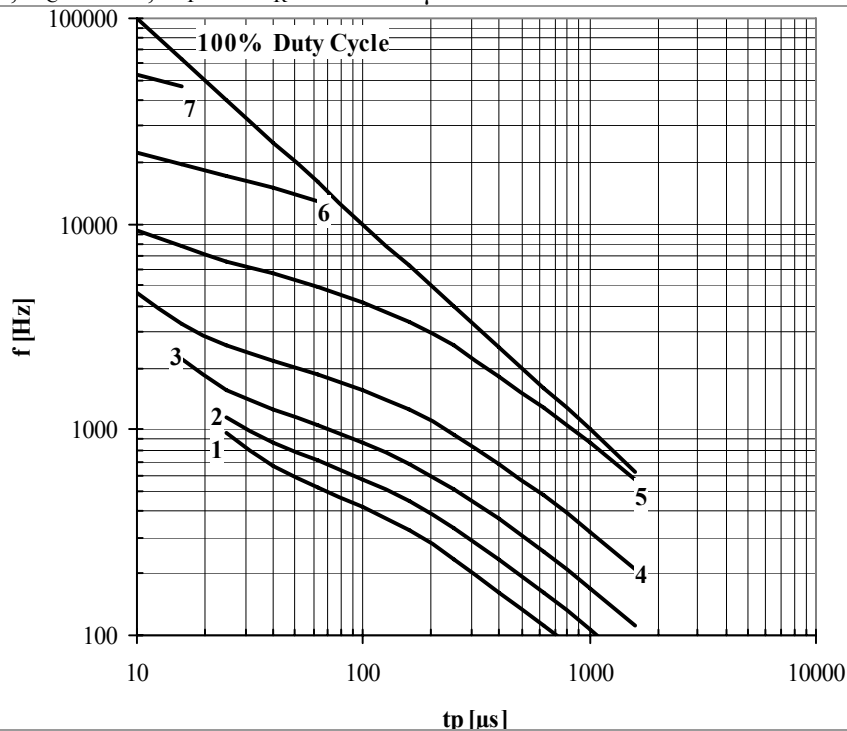


Fig. 15 Square wave frequency ratings

- 1 – $I_{TM} = 5000 \text{ A}$
- 2 – $I_{TM} = 4000 \text{ A}$
- 3 – $I_{TM} = 3000 \text{ A}$
- 4 – $I_{TM} = 2000 \text{ A}$
- 5 – $I_{TM} = 1000 \text{ A}$
- 6 – $I_{TM} = 500 \text{ A}$
- 7 – $I_{TM} = 250 \text{ A}$

Conditions: $V_R \leq 3 \text{ V}$; $T_C = 55 \text{ }^\circ\text{C}$; $di_F/dt = di_R/dt = 500 \text{ A}/\mu\text{s}$

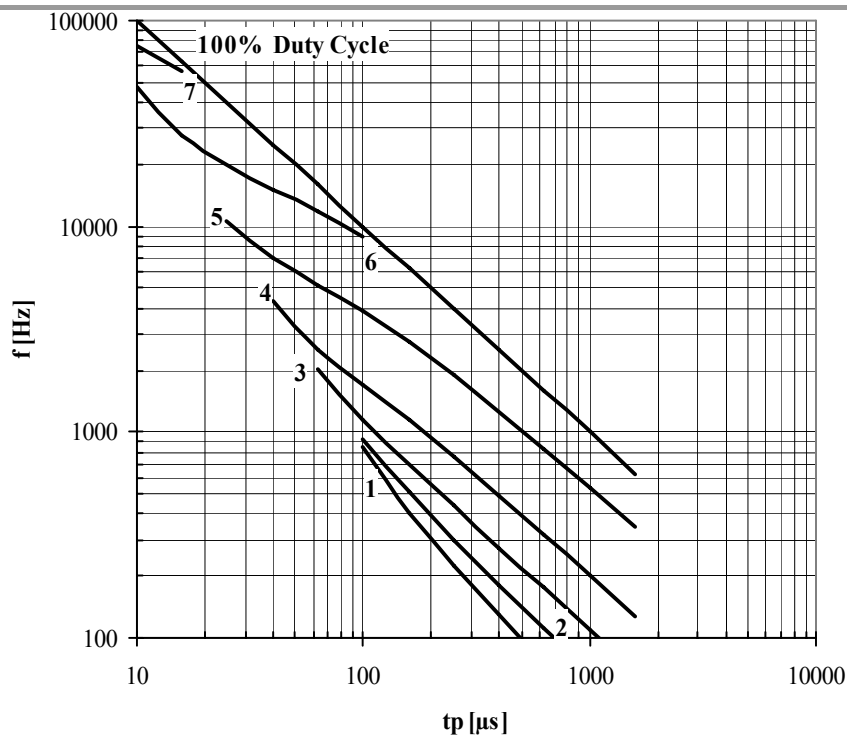


Fig. 16 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $T_C = 85$ °C; $di_F/dt = di_R/dt = 100$ A/ μ s

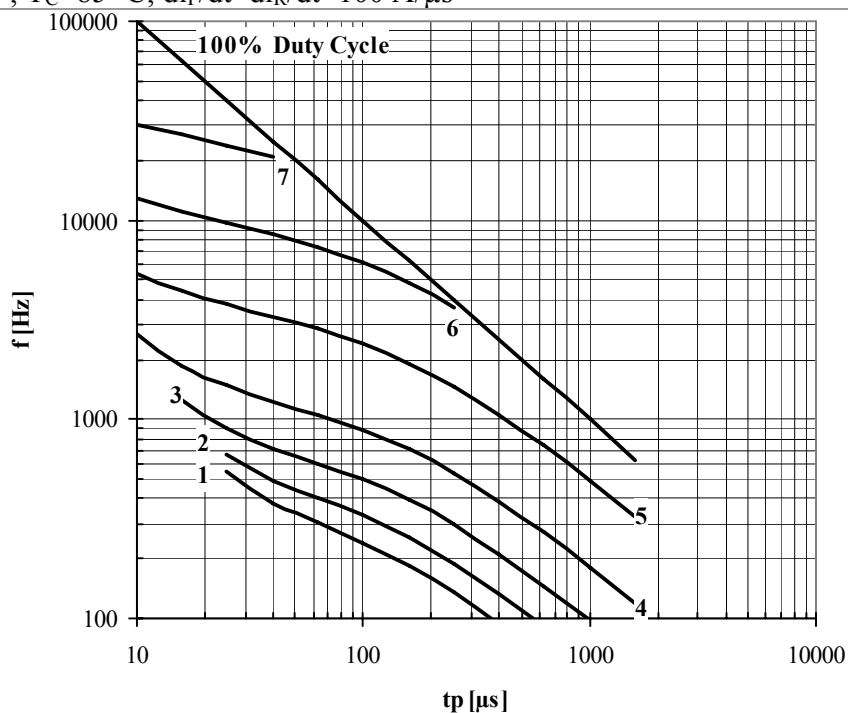


Fig. 17 Square wave frequency ratings

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $T_C = 85$ °C; $di_F/dt = di_R/dt = 500$ A/ μ s

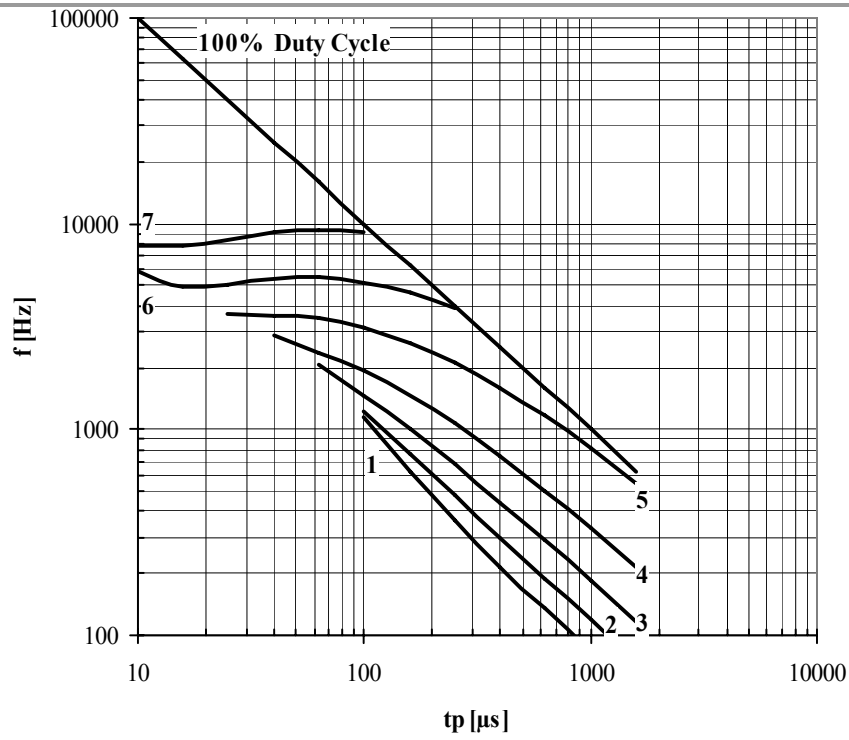


Fig. 18 Square wave frequency ratings

1 – $I_{TM} = 5000$ A

2 – $I_{TM} = 4000$ A

3 – $I_{TM} = 3000$ A

4 – $I_{TM} = 2000$ A

5 – $I_{TM} = 1000$ A

6 – $I_{TM} = 500$ A

7 – $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 55$ °C; $di_F/dt = di_R/dt = 100$ A/ μ s

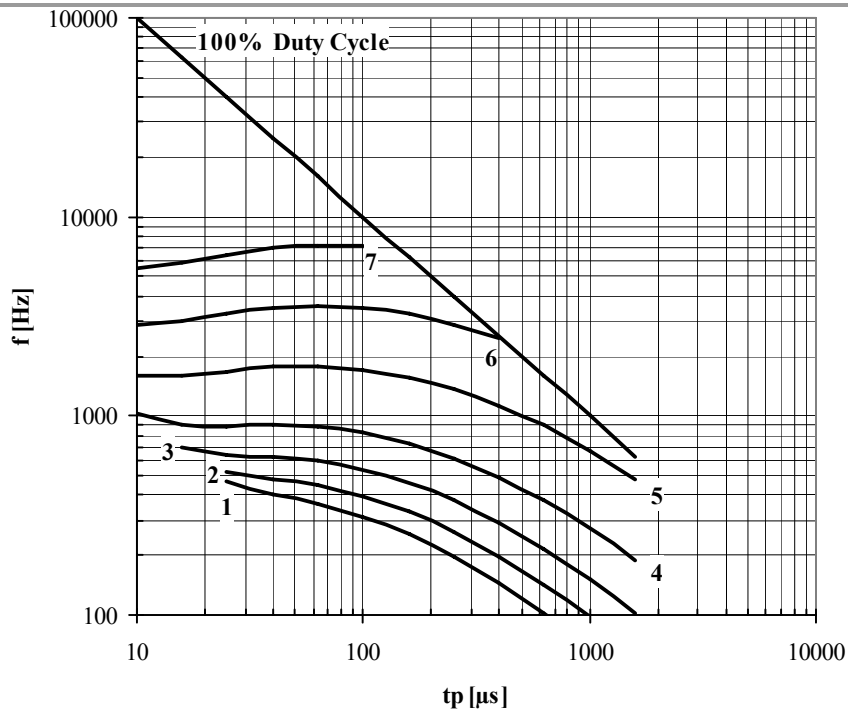


Fig. 19 Square wave frequency ratings

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$; $T_C = 55$ °C; $di_F/dt = di_R/dt = 500$ A/μs

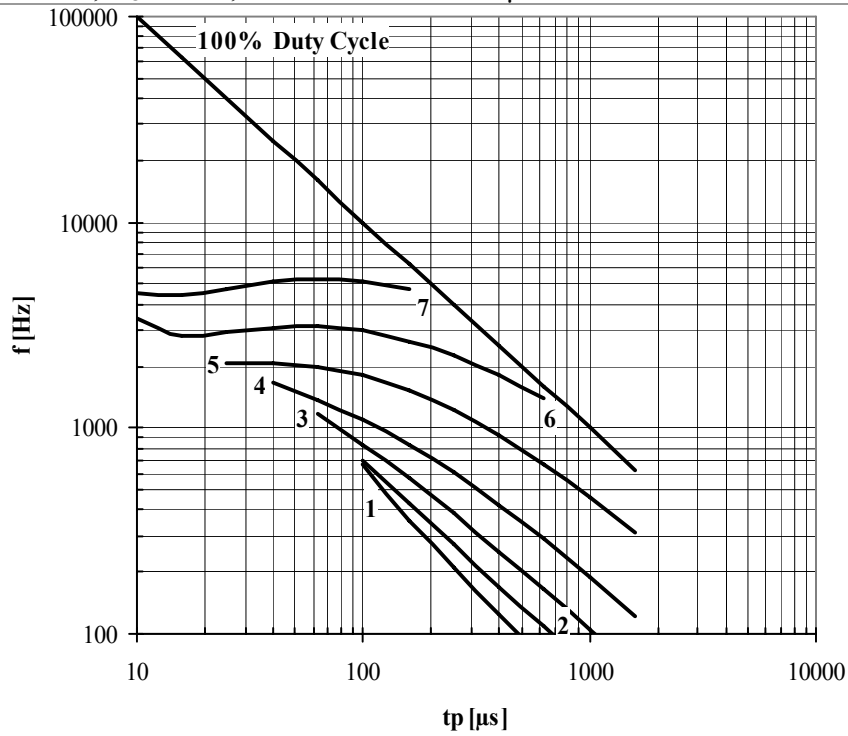


Fig. 20 Square wave frequency ratings

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R = 0.67 V_{RRM}$; $T_C = 85$ °C; $di_F/dt = di_R/dt = 100$ A/ μ s

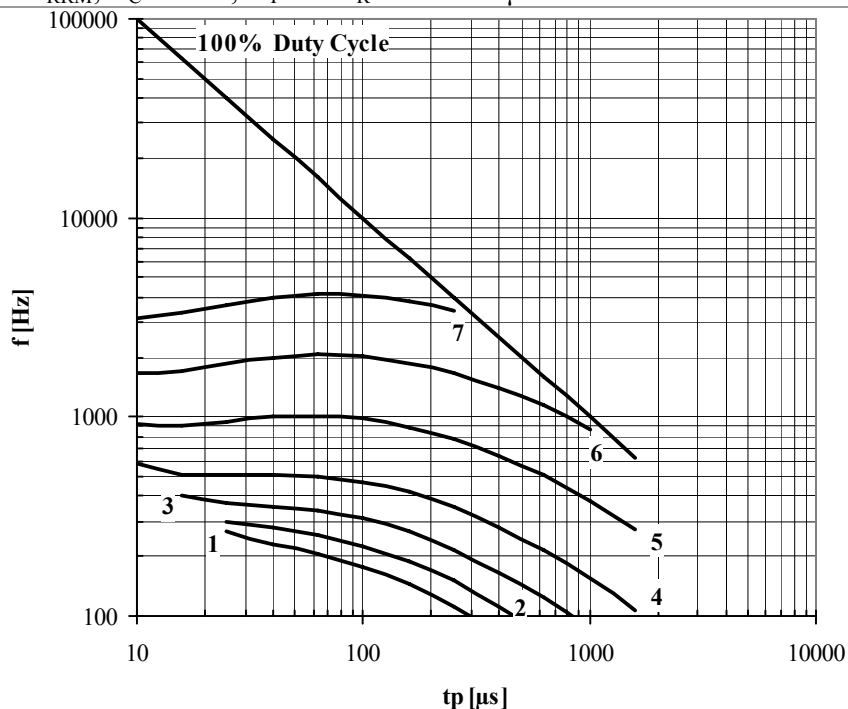


Fig. 21 Square wave frequency ratings

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R = 0.67 V_{RRM}$; $T_C = 85$ °C; $di_F/dt = di_R/dt = 500$ A/ μ s

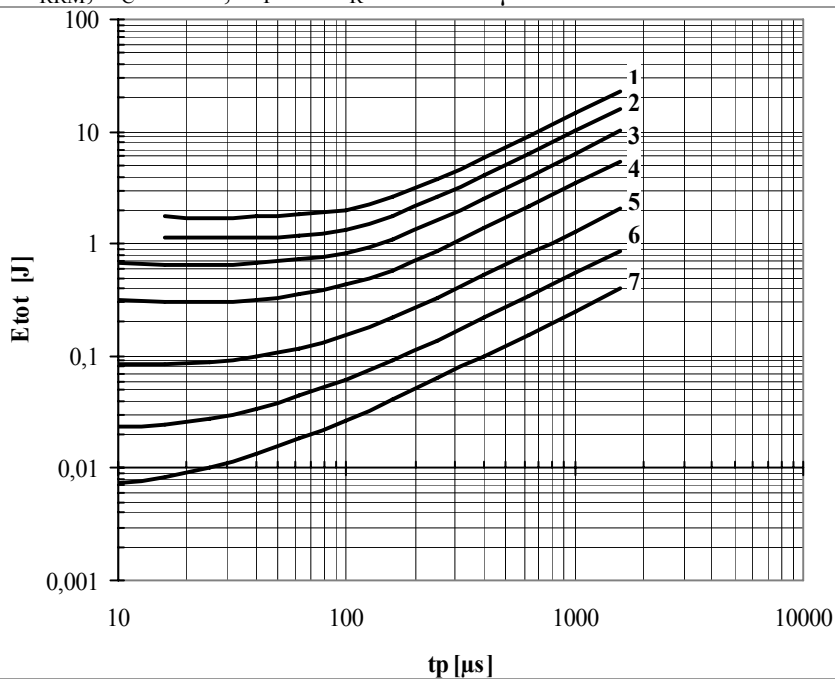


Fig. 22 Sine wave loss energy per pulse

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V

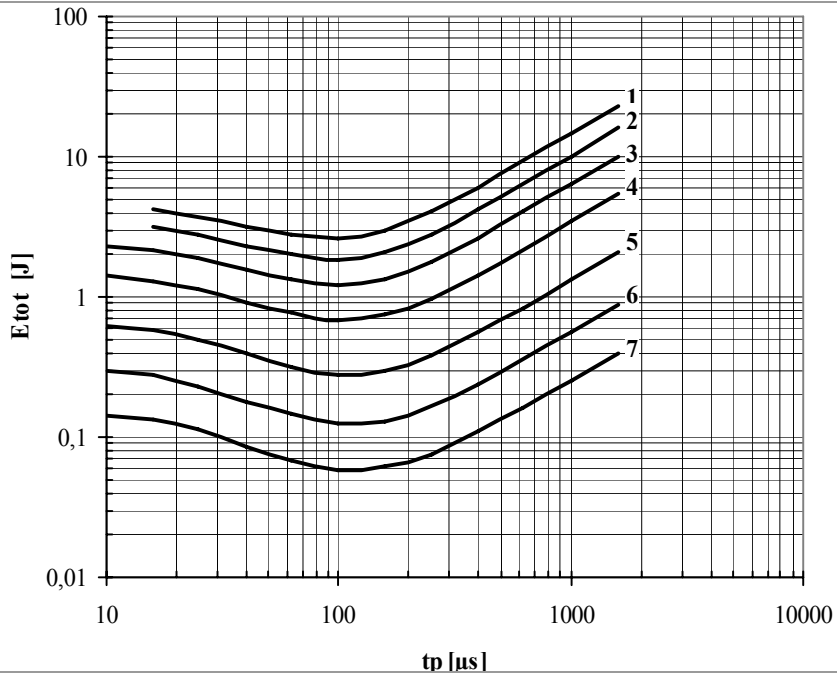


Fig. 23 Sine wave loss energy per pulse

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R = 0.67 \cdot V_{RRM}$

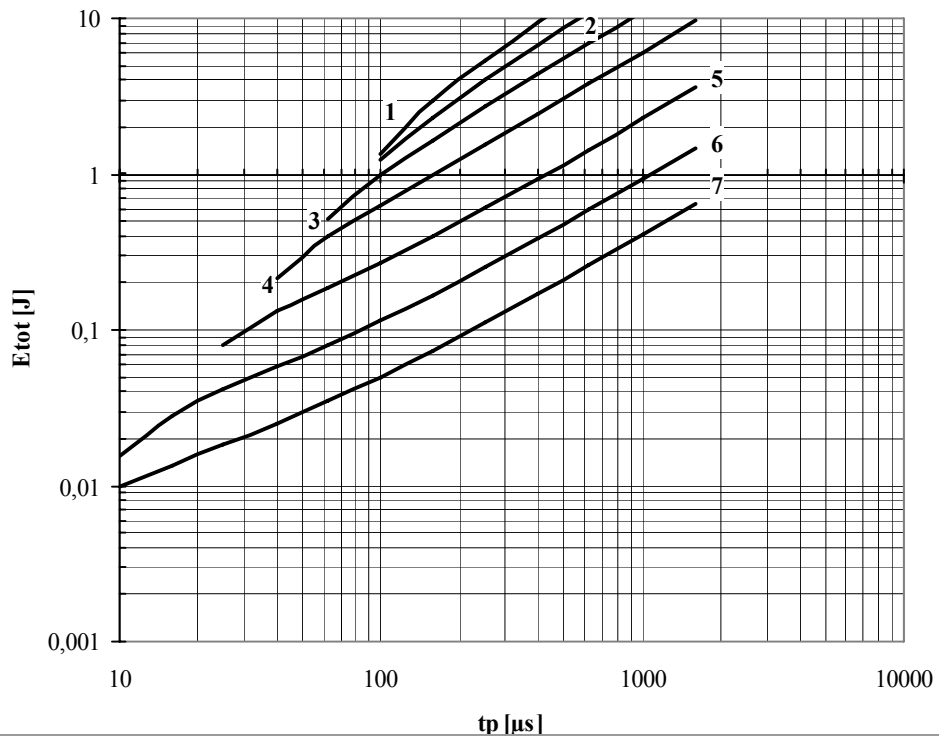


Fig. 24 Square wave loss energy per pulse

1 – $I_{TM} = 5000$ A

2 – $I_{TM} = 4000$ A

3 – $I_{TM} = 3000$ A

4 – $I_{TM} = 2000$ A

5 – $I_{TM} = 1000$ A

6 – $I_{TM} = 500$ A

7 – $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $di_F/dt = di_R/dt = 100$ A/ μ s

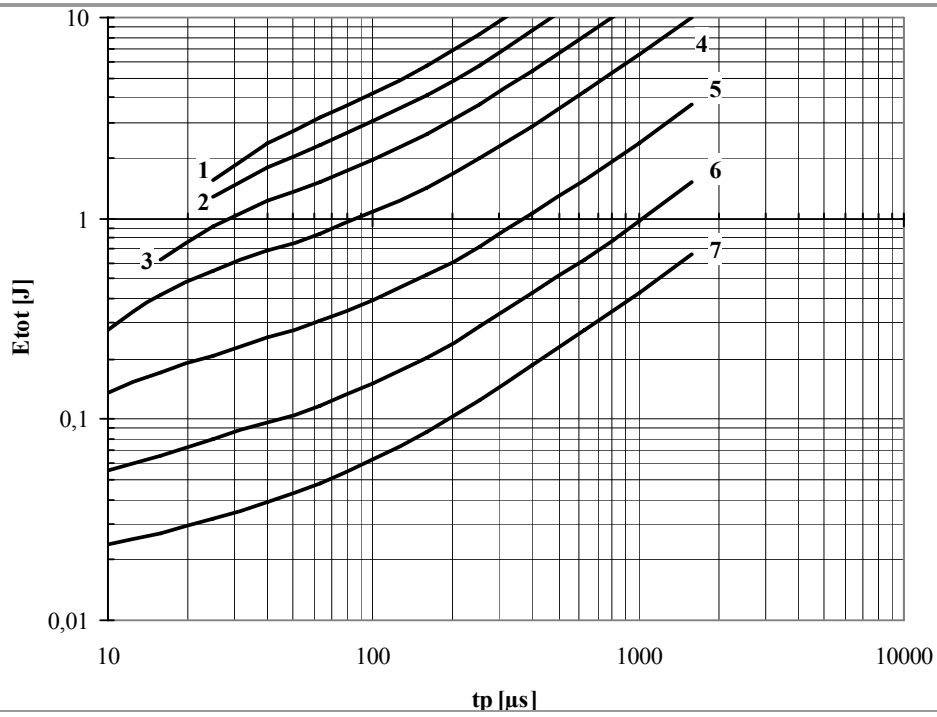


Fig. 25 Square wave loss energy per pulse

- 1 – $I_{TM} = 5000$ A
- 2 – $I_{TM} = 4000$ A
- 3 – $I_{TM} = 3000$ A
- 4 – $I_{TM} = 2000$ A
- 5 – $I_{TM} = 1000$ A
- 6 – $I_{TM} = 500$ A
- 7 – $I_{TM} = 250$ A

Conditions: $V_R \leq 3$ V; $di_F/dt = di_R/dt = 500$ A/ μ s

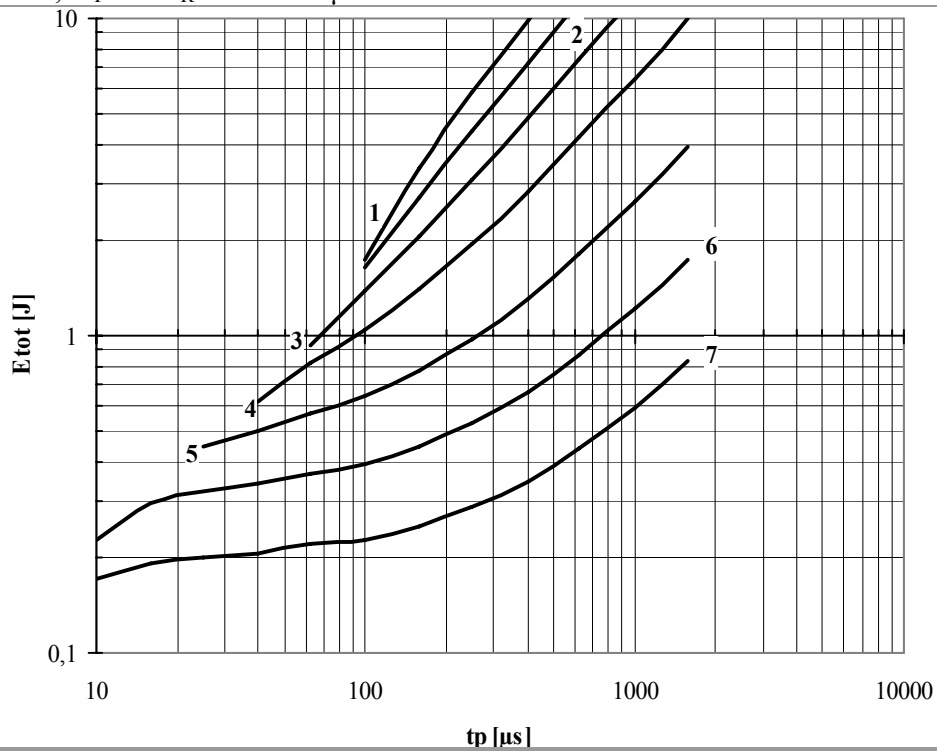


Fig. 26 Square wave loss energy per pulse

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 V_{RRM}$; $di_F/dt = di_R/dt = 100$ A/ μ s

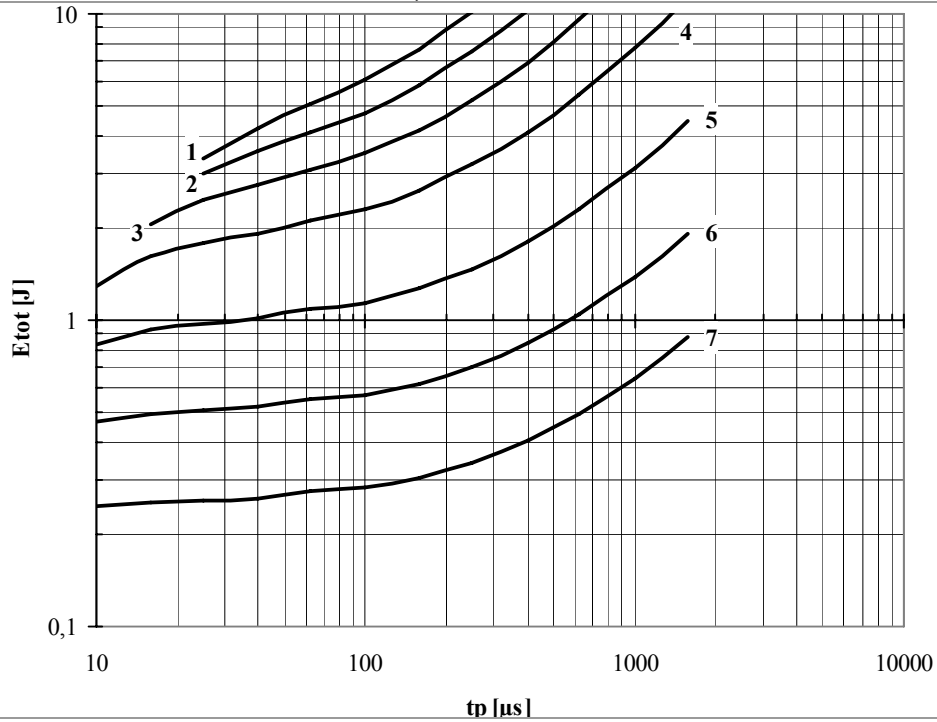


Fig. 27 Square wave loss energy per pulse

- 1 - $I_{TM} = 5000$ A
- 2 - $I_{TM} = 4000$ A
- 3 - $I_{TM} = 3000$ A
- 4 - $I_{TM} = 2000$ A
- 5 - $I_{TM} = 1000$ A
- 6 - $I_{TM} = 500$ A
- 7 - $I_{TM} = 250$ A

Conditions: $V_R = 0.67 V_{RRM}$; $di_F/dt = di_R/dt = 500$ A/ μ s

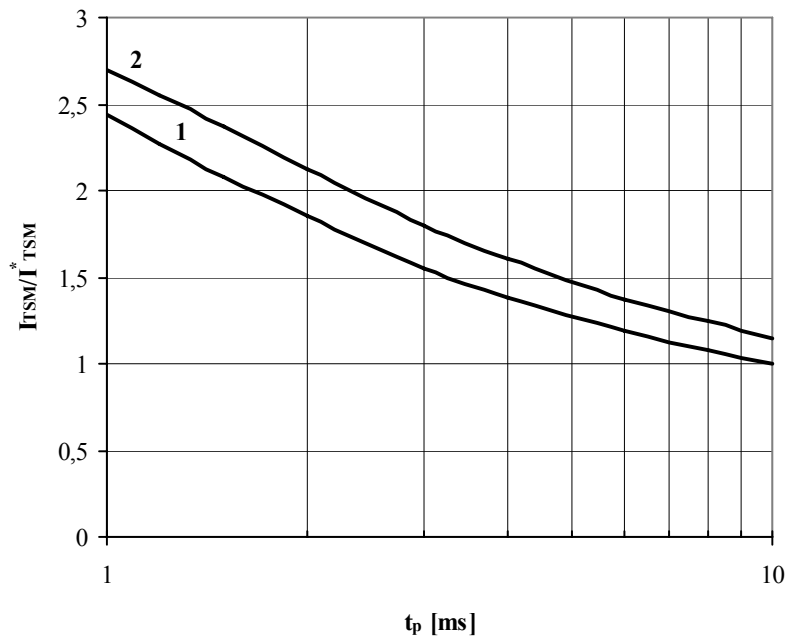


Fig. 28 The surge current I_{TSM} vs. Duration of surge t_p for a half-sine wave
 1 – $T_j = 125^\circ\text{C}$
 2 – $T_j = 25^\circ\text{C}$

Conditions: $V_R = 0\text{ V}$ – the peak value of reverse voltage which is applied immediately after the surge current

Typical changes of I_{TSM} are normalized to the I_{TSM}^* (I_{TSM}^* – see data sheet, $T_j = T_{j\text{max}}$)

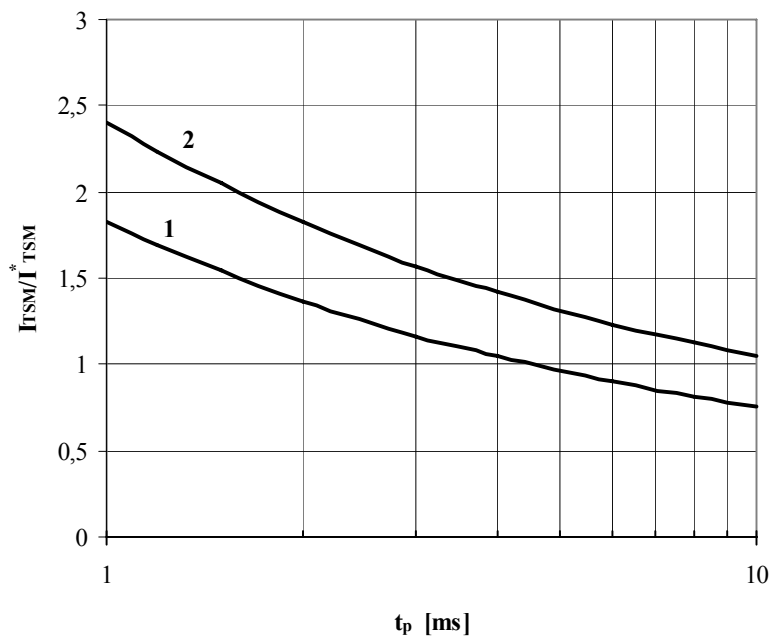


Fig. 29 The surge current I_{TSM} vs. Duration of surge t_p for a half-sine wave
 1 – $T_j = 125^\circ\text{C}$
 2 – $T_j = 25^\circ\text{C}$

Conditions: $V_R = 0.8 \cdot V_{RRM}$ – the peak value of reverse voltage which is applied immediately after the surge current

Typical changes of I_{TSM} are normalized to the I_{TSM}^* (I_{TSM}^* – see data sheet, $T_j = T_{j\text{max}}$)

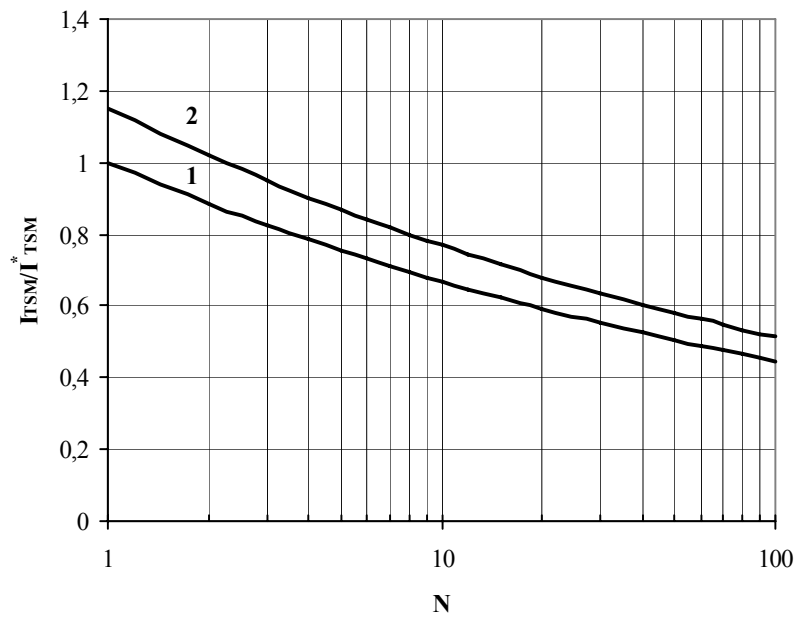


Fig. 30 The surge current I_{TSM} vs. Number of half-sine waves at 50 Hz
 1 – $T_j=125^\circ\text{C}$
 2 – $T_j=25^\circ\text{C}$

Conditions: $V_R=0\text{ V}$ – the peak value of reverse voltage which is applied immediately after the surge current

Typical changes of I_{TSM} are normalized to the I_{TSM}^* (I_{TSM}^* – see data sheet, $T_j=T_{j\text{max}}$)

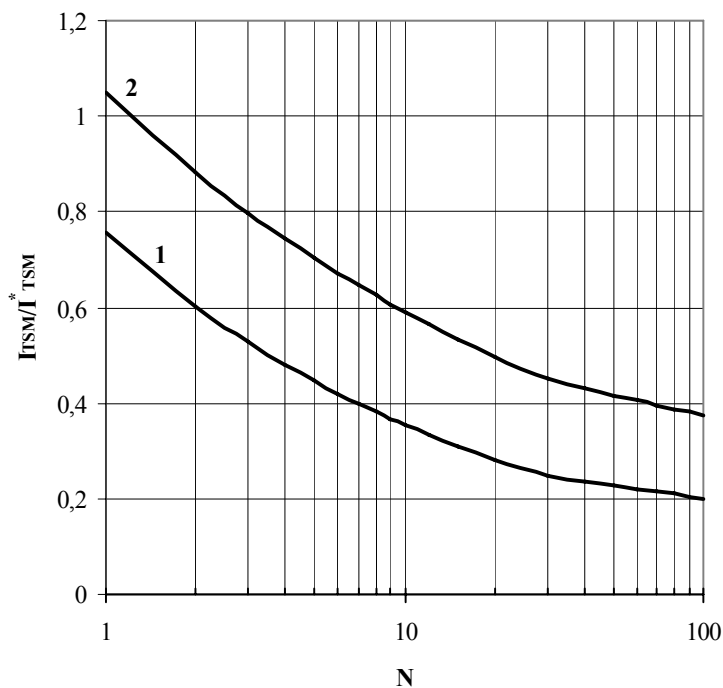


Fig. 31 The surge current I_{TSM} vs. Number of half-sine waves at 50 Hz
 1 – $T_j=125^\circ\text{C}$
 2 – $T_j=25^\circ\text{C}$

Conditions: $V_R=0.8 \cdot V_{RRM}$ – the peak value of reverse voltage which is applied immediately after the surge current

Typical changes of I_{TSM} are normalized to the I_{TSM}^* (I_{TSM}^* – see data sheet, $T_j=T_{j\text{max}}$)